30V N-CHANNEL ENHANCEMENT MODE MOSFET

SUMMARY

 $V_{(BR)DSS} = 30V; R_{DS(ON)} = 0.025\Omega I_D = 9.0A$

DESCRIPTION

This new generation of TRENCH MOSFETs from Zetex utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.



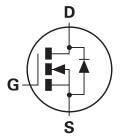
SO8

FEATURES

- · Low on-resistance
- · Fast switching speed
- Low threshold
- Low gate drive
- Low profile SOIC package

APPLICATIONS

- Disconnect switches
- Motor control



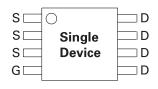
ORDERING INFORMATION

DEVICE	REEL SIZE	TAPE WIDTH	QUANTITY PER REEL
ZXMN3A02N8TA	7″	12mm	500 units
ZXMN3A02N8TC	13"	12mm	2500 units

DEVICE MARKING

 ZXMN 3A02

PINOUT



Top View



ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V _{DSS}	30	V
Gate Source Voltage	V_{GS}	±20	V
Continuous Drain Current V_{GS} =-10V; T_A =25°C (b) V_{GS} =-10V; T_A =70°C (b) V_{GS} =-10V; T_A =25°C (a)	I _D	9.0 7.2 7.3	А
Pulsed Drain Current (c)	I _{DM}	44	А
Continuous Source Current (Body Diode) (b)	I _S	3.2	А
Pulsed Source Current (Body Diode) (c)	I _{SM}	44	А
Power Dissipation at T _A =25°C (a) Linear Derating Factor	P _D	1.56 12.5	W mW/°C
Power Dissipation at T _A =25°C (b) Linear Derating Factor	P _D	2.5 20	W mW/°C
Operating and Storage Temperature Range	T _j :T _{stg}	-55 to +150	°C

THERMAL RESISTANCE

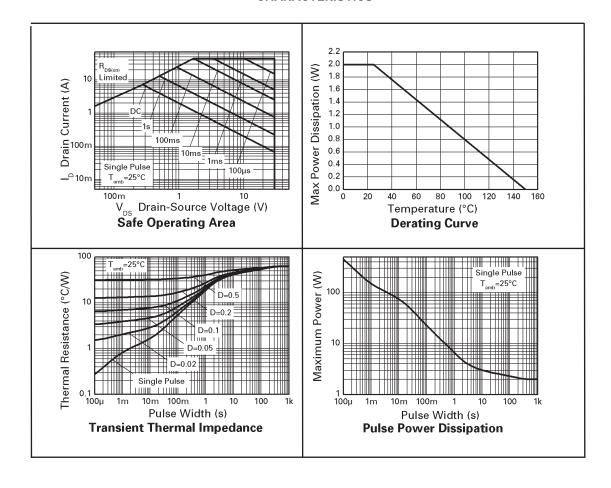
PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)	$R_{\theta JA}$	80	°C/W
Junction to Ambient (b)	$R_{\theta JA}$	50	°C/W



⁽a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions

 ⁽b) For a device surface mounted on FR4 PCB measured at t≤10 secs.
(c) Repetitive rating 25mm x 25mm FR4 PCB, D = 0.02, pulse width 300µs - pulse width limited by maximum junction temperature.

CHARACTERISTICS





ELECTRICAL CHARACTERISTICS (at $T_{amb} = 25$ °C unless otherwise stated).

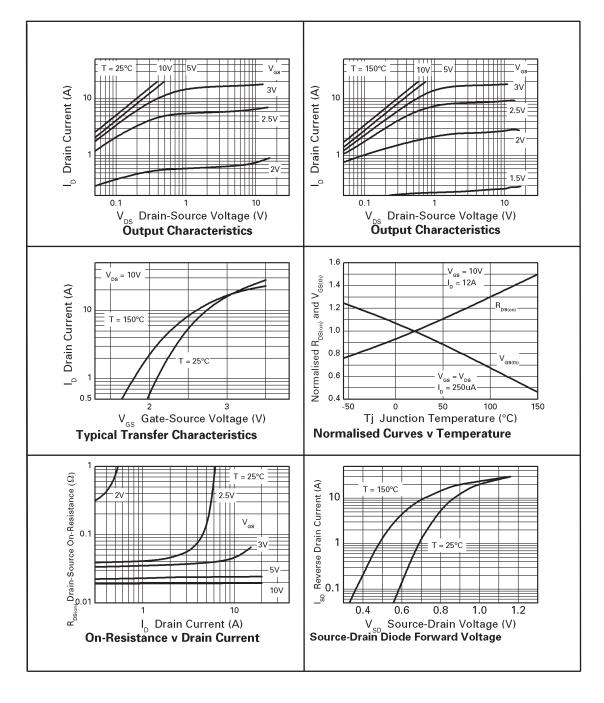
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PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS.	
STATIC	STATIC						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	30			V	I _D =250μA, V _{GS} =0V	
Zero Gate Voltage Drain Current	I _{DSS}			1	μΑ	V _{DS} =30V, V _{GS} =0V	
Gate-Body Leakage	I _{GSS}			100	nA	V_{GS} = $\pm 20V$, V_{DS} = $0V$	
Gate-Source Threshold Voltage	V _{GS(th)}	1.0			V	I _D =250μA, V _{DS} = V _{GS}	
Static Drain-Source On-State Resistance (1)	R _{DS(on)}			0.025 0.035	Ω	V _{GS} =10V, I _D =12A V _{GS} =4.5V, I _D =10.2A	
Forward Transconductance (1)(3)	9fs		22		S	V _{DS} =10V,I _D =12A	
DYNAMIC (3)		•	•		•		
Input Capacitance	C _{iss}		1400		pF		
Output Capacitance	Coss		209		pF	V _{DS} =25V, V _{GS} =0V, f=1MHz	
Reverse Transfer Capacitance	C _{rss}		120		pF		
SWITCHING(2) (3)		•		•			
Turn-On Delay Time	t _{d(on)}		3.9		ns	V_{DD} =10V, I_{D} =1A R_{G} \(\text{\text{\text{\$\geq}}}6.0\Omega\), V_{GS} =4.5V (refer to test circuit)	
Rise Time	t _r		5.5		ns		
Turn-Off Delay Time	t _d (off)		35.0		ns		
Fall Time	t _f		7.6		ns		
Gate Charge	Qg		14.5		nC	V _{DS} =15V,V _{GS} =5V, I _D =5.5A (refer to test circuit)	
Total Gate Charge	Qg		26.8		nC	-V _{DS} =15V,V _{GS} =10V,	
Gate-Source Charge	Qgs		4.7		nC	I _D =5.5A	
Gate-Drain Charge	Q _{gd}		4.7		nC	(refer to test circuit)	
SOURCE-DRAIN DIODE							
Diode Forward Voltage (1)	V_{SD}		0.85	0.95	V	TJ=25°C, IS=9A, VGS=0V	
Reverse Recovery Time (3)	t _{rr}		17		ns	T _J =25°C, I _F =5.5A, di/dt= 100A/μs	
Reverse Recovery Charge (3)	Q _{rr}		8.3		nC		

NOTES

- (1) Measured under pulsed conditions. Width ${\leq}300\mu s.$ Duty cycle ${\leq}~2\%$.
- (2) Switching characteristics are independent of operating junction temperature.
- (3) For design aid only, not subject to production testing.

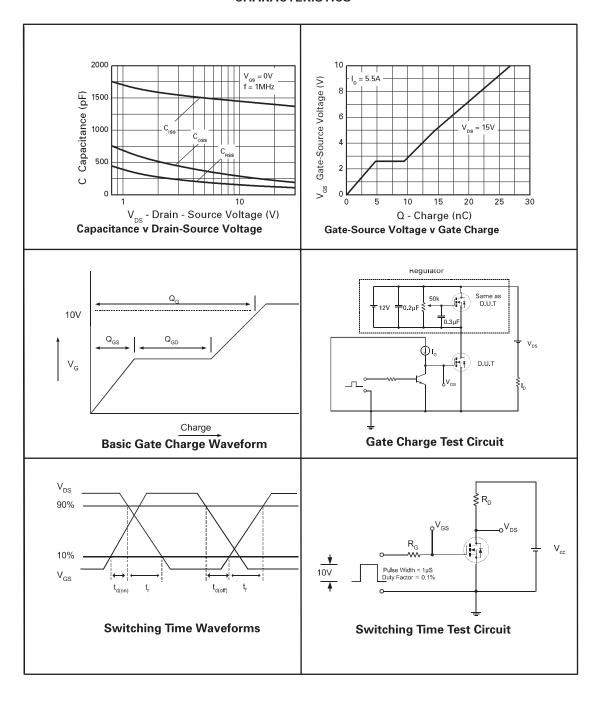


CHARACTERISTICS



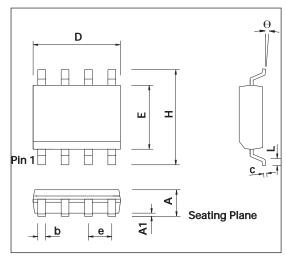


CHARACTERISTICS





PACKAGE OUTLINE



CONTROLLING DIMENSIONS ARE IN INCHES APPROX IN MILLIMETRES

PACKAGE DIMENSIONS

DIM	INCI	HES	MILLIMETRES		
DIIVI	MIN	MAX	MIN	MAX	
А	0.053	0.069	1.35	1.75	
A1	0.004	0.010	0.10	0.25	
D	0.189	0.197	4.80	5.00	
Н	0.228	0.244	5.80	6.20	
Е	0.150	0.157	3.80	4.00	
L	0.016	0.050	0.40	1.27	
е	0.050	0.050 BSC		BSC	
b	0.013	0.020	0.33	0.51	
С	0.008	0.010	0.19	0.25	
θ	0°	8°	0°	8°	
h	0.010	0.020	0.25	0.50	

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